Docket No.: ASMNUT.088A Page 1 of 1

Please Direct All Correspondence to Customer Number **20995**

AMENDMENT / RESPONSE TRANSMITTAL

Applicant

Basol et al.

App. No

09/960,236

Filed

September 20, 2001

For

MASK PLATE DESIGN

Examiner

Lois L. Zheng

Art Unit

1742

CERTIFICATE OF MAILING

I hereby certify that this correspondence and all marked attachments are being deposited with the United States Postal Service as first-class mail in an envelope addressed to: Commissioner for Patents, P.O. Box 1450, Alexandria, VA 22313-1450, on

September 25, 2006

(Date) .

Tina Chen, Reg. No. 44,606

Mail Stop AF

Commissioner for Patents P.O. Box 1450 Alexandria, VA 22313-1450

Sir:

Transmitted herewith for filing in the above-identified application are the following enclosures:

- (X) Response to Final Office Action in 10 pages.
- (X) Return prepaid postcard.

Please charge any additional fees, including any fees for additional extension of time, or credit overpayment to Deposit Account No. 11-1410.

Tina Chen

Registration No. 44,606

Attorney of Record

Customer No. 20,995

(415) 954-4114

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IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

Applicant

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RESPONSE TO FINAL OFFICE ACTION

Mail Stop AF

Commissioner for Patents P.O. Box 1450 Alexandria, VA 22313-1450

Dear Sir:

In response to the final Office Action mailed on July 24, 2006, please amend the above-captioned application as set forth herein.

Amendments to the Claims are reflected in the listing of claims which begins on page 2 of this paper.

Remarks/Arguments begin on page 9 of this paper.